## Notice of References Cited Application/Control No. 10/594,466 Examiner SAM RIZK Applicant(s)/Patent Under Reexamination KIM ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-2002/0194570	12-2002	Birru et al.	714/792	
*	В	US-2005/0271158	12-2005	Birru, Dagnachew	375/270	
*	С	US-7,197,685	03-2007	Limberg, Allen LeRoy	714/756	
	D	US-				
	Е	US-				
	F	US-				
	G	US-				
	Н	US-				
	I	US-				
	J	US-				
	K	US-				
	L	US-				
	М	US-				

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.